



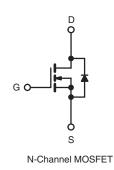
N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.027			
Q _g (Max.) (nC)	95				
Q _{gs} (nC)	27				
Q _{gd} (nC)	46				
Configuration	Single				

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS $T_C = 25 \degree C$, unless otherwise noted								
PARAMETER			SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V _{DS}	60	v				
Gate-Source Voltage			V _{GS}	± 20	v			
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	45				
	VGS at 10 V	$T_C = 100 ^{\circ}C$		30	А			
Pulsed Drain Current ^a			I _{DM}	220				
Linear Derating Factor			0.32	W/°C				
Single Pulse Avalanche Energy ^b		E _{AS}	100	mJ				
Maximum Power Dissipation	T _C = 25 °C		PD	52	W			
Peak Diode Recovery dV/dt ^c		dV/dt	4.5	V/ns				
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C				
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d				
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in			
				1.1	N · m			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 129 µH, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \le 52 \text{ A}$, dl/dt $\le 250 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.



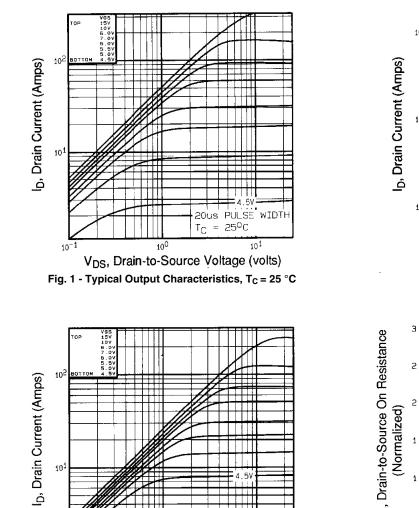


THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				°C/W		
SPECIFICATIONS $T_J = 25 °C$,	unless otherw	vise noted						
PARAMETER	SYMBOL		CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static		I						J
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA			60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C,	I _D = 1 mA	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	′ _{GS} , I _D = 2	50 μA	1.0	-	3.0	V
Gate-Source Leakage	I _{GSS}	V _G	$_{iS} = \pm 20$	V	-	-	± 100	nA
	000	V _{DS} = 6	$V_{DS} = 60 V, V_{GS} = 0 V$		-	-	25	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 48 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 \text{ °C}$			-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		= 18 A ^b	-	0.027	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 2	25 V, I _D =	18 A ^b	15	-	-	S
Dynamic						•		•
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz			-	1500	-	
Output Capacitance	C _{oss}			-	720	-	рF	
Reverse Transfer Capacitance	C _{rss}			-	100	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg) = 52 A, V _{DS} = 48 V, see fig. 6 and 13 ^b	-	-	95	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 52 A$		-	-	27	
Gate-Drain Charge	Q _{gd}		see ng	J. 6 anu 13-	-	-	46	
Turn-On Delay Time	t _{d(on)}				-	19	-	
Rise Time	tr	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{\rm DD} = 30 \; {\sf V}, \; {\sf I}_{\rm D} = 52 \; {\sf A}, \\ {\sf R}_{\rm G} = 9.1 \; \Omega, \; {\sf R}_{\rm D} = 0.54 \; \Omega, \\ {\sf see \; fig. \; 10^{\rm b}} \end{array}$		-	120	-	- ns	
Turn-Off Delay Time	t _{d(off)}			-	55	-		
Fall Time	t _f			-	86	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	Ls			-	7.5	-		
Drain-Source Body Diode Characteristic	s	l				1		1
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	45	A	
Pulsed Diode Forward Currenta	I _{SM}			-	-	120		
Body Diode Voltage	V_{SD}	$T_J = 25 \text{ °C}, I_S = 30 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^{\circ}C, \ I_F = 52 \ A, \ dI/dt = 100 \ A/\mu s^b$		-	140	300	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and				/ L _S and L	_D)	

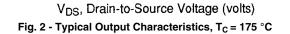
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



100

20us PULSE

 $T_{\rm C} = 175^{\rm O}{\rm C}$

WTD

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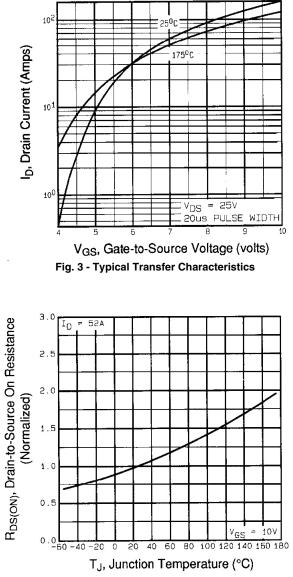


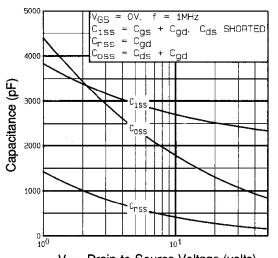
Fig. 4 - Normalized On-Resistance vs. Temperature

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V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

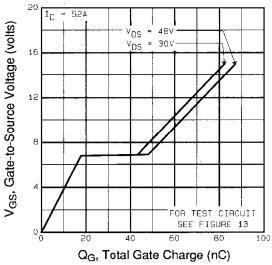


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

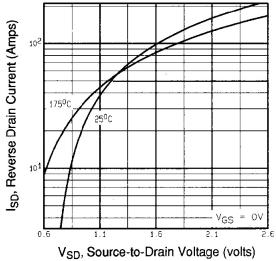
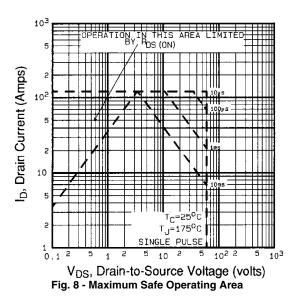


Fig. 7 - Typical Source-Drain Diode Forward Voltage



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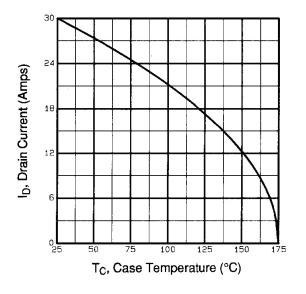


Fig. 9 - Maximum Drain Current vs. Case Temperature

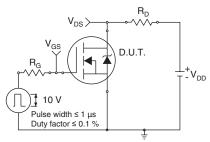


Fig. 10a - Switching Time Test Circuit

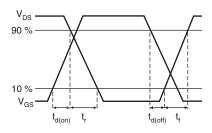


Fig. 10b - Switching Time Waveforms

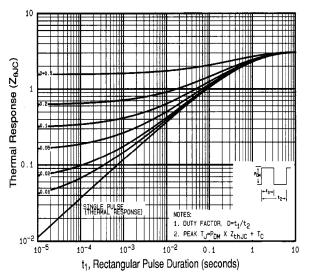


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

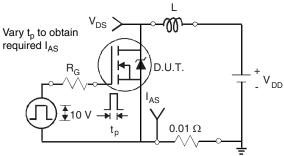


Fig. 12a - Unclamped Inductive Test Circuit

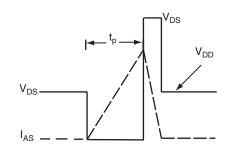
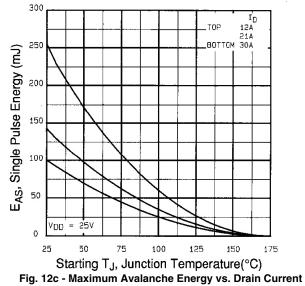
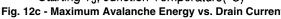


Fig. 12b - Unclamped Inductive Waveforms







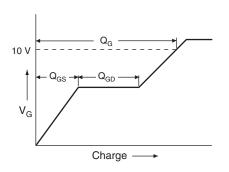


Fig. 13a - Basic Gate Charge Waveform

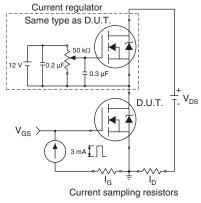
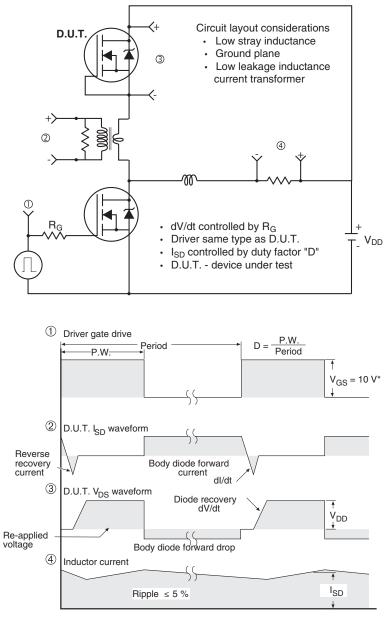


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



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